

74ABT827

10-bit buffer/line driver; non-inverting; 3-state

Rev. 04 — 1 April 2010

Product data sheet

1. General description

The 74ABT827 high-performance BiCMOS device combines low static and dynamic power dissipation with high speed and high output drive.

The 74ABT827 10-bit buffers provide high performance bus interface buffering for wide data/address paths or buses carrying parity. They have NOR Output Enables (\overline{OE}_0 , \overline{OE}_1) for maximum control flexibility.

2. Features and benefits

- Ideal where high speed, light loading, or increased fan-in are required
- Flow-through pinout architecture for microprocessor oriented applications
- Output capability: +64 mA and –32 mA
- Power-up 3-state
- Inputs are disabled during 3-state mode
- Latch-up protection exceeds 500 mA per JESD78B class II level A
- ESD protection:
 - ◆ HBM JESD22-A114F exceeds 2000 V
 - ◆ MM JESD22-A115-A exceeds 200 V

3. Ordering information

Table 1. Ordering information

| Type number | Package | | | | Version |
|-------------|-------------------|---------|--|--|----------|
| | Temperature range | Name | Description | | |
| 74ABT827D | –40 °C to +85 °C | SO24 | plastic small outline package; 24 leads; body width 7.5 mm | | SOT137-1 |
| 74ABT827DB | –40 °C to +85 °C | SSOP24 | plastic shrink small outline package; 24 leads; body width 5.3 mm | | SOT340-1 |
| 74ABT827PW | –40 °C to +85 °C | TSSOP24 | plastic thin shrink small outline package; 24 leads; body width 4.4 mm | | SOT355-1 |



4. Functional diagram

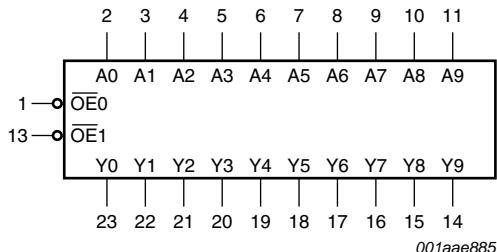


Fig 1. Logic symbol

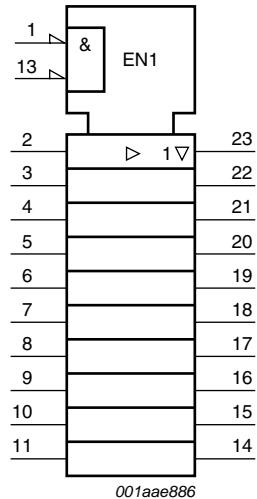


Fig 2. IEEE/IEC logic symbol

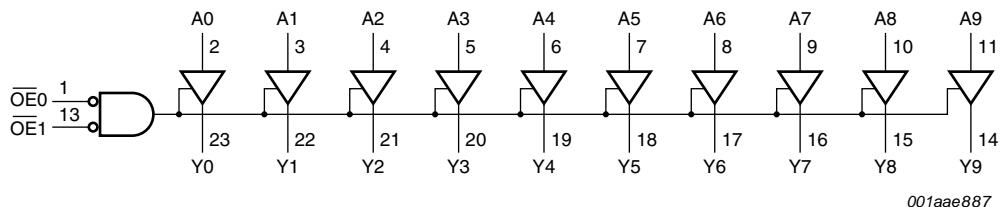


Fig 3. Logic diagram

5. Pinning information

5.1 Pinning

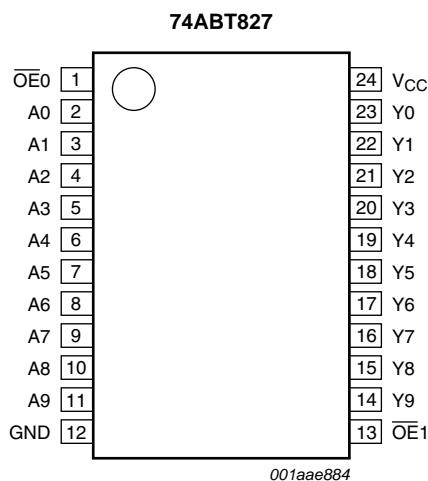


Fig 4. Pin configuration

5.2 Pin description

Table 2. Pin description

| Symbol | Pin | Description |
|-----------------|--|----------------------------------|
| OE0 | 1 | output enable input (active LOW) |
| A0 to A9 | 2, 3, 4, 5, 6, 7, 8, 9, 10, 11 | data input |
| GND | 12 | ground (0 V) |
| OE1 | 13 | output enable input (active LOW) |
| Y0 to Y9 | 23, 22, 21, 20, 19, 18, 17, 16, 15, 14 | data output |
| V _{CC} | 24 | supply voltage |

6. Functional description

6.1 Function table

Table 3. Function table^[1]

| Inputs | | Output | Operating mode |
|--------|----|--------|----------------|
| OEn | An | Yn | |
| L | L | L | transparent |
| L | H | H | transparent |
| H | X | Z | high-impedance |

[1] H = HIGH voltage level;

L = LOW voltage level;

X = don't care;

Z = high-impedance OFF-state.

7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|------------------|-------------------------|-----------------------------------|----------|------|------|
| V _{CC} | supply voltage | | -0.5 | +7.0 | V |
| V _I | input voltage | | [1] -1.2 | +7.0 | V |
| V _O | output voltage | output in OFF-state or HIGH-state | [1] -0.5 | +5.5 | V |
| I _{IK} | input clamping current | V _I < 0 V | -18 | - | mA |
| I _{OK} | output clamping current | V _O < 0 V | -50 | - | mA |
| I _O | output current | output in LOW-state | - | 128 | mA |
| T _j | junction temperature | | [2] - | 150 | °C |
| T _{stg} | storage temperature | | -65 | +150 | °C |

[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

[2] The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150 °C.

8. Recommended operating conditions

Table 5. Recommended operating conditions

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|------------------|-------------------------------------|-------------|-----|-----|-----------------|------|
| V _{CC} | supply voltage | | 4.5 | - | 5.5 | V |
| V _I | input voltage | | 0 | - | V _{CC} | V |
| V _{IH} | HIGH-level input voltage | | 2.0 | - | - | V |
| V _{IL} | LOW-level input voltage | | - | - | 0.8 | V |
| I _{OH} | HIGH-level output current | | -32 | - | - | mA |
| I _{OL} | LOW-level output current | | - | - | 64 | mA |
| Δt/ΔV | input transition rise and fall rate | | 0 | - | 5 | ns/V |
| T _{amb} | ambient temperature | in free air | -40 | - | +85 | °C |

9. Static characteristics

Table 6. Static characteristics

| Symbol | Parameter | Conditions | 25 °C | | | −40 °C to +85 °C | | Unit |
|-----------------------|------------------------------------|---|-------|-------|------|------------------|------|--------|
| | | | Min | Typ | Max | Min | Max | |
| V_{IK} | input clamping voltage | $V_{CC} = 4.5 \text{ V}; I_{IK} = -18 \text{ mA}$ | -1.2 | -0.9 | - | -1.2 | - | V |
| V_{OH} | HIGH-level output voltage | $V_I = V_{IL} \text{ or } V_{IH}$ | | | | | | |
| | | $V_{CC} = 4.5 \text{ V}; I_{OH} = -3 \text{ mA}$ | 2.5 | 2.9 | - | 2.5 | - | V |
| | | $V_{CC} = 5.0 \text{ V}; I_{OH} = -3 \text{ mA}$ | 3.0 | 3.4 | - | 3.0 | - | V |
| V_{OL} | LOW-level output voltage | $V_{CC} = 4.5 \text{ V}; I_{OL} = 64 \text{ mA}; V_I = V_{IL} \text{ or } V_{IH}$ | - | 0.42 | 0.55 | - | 0.55 | V |
| | | $V_{CC} = 5.5 \text{ V}; V_I = \text{GND or } 5.5 \text{ V}$ | - | ±0.01 | ±1.0 | - | ±1.0 | µA |
| | | $V_{CC} = 0 \text{ V}; V_I \text{ or } V_O \leq 4.5 \text{ V}$ | - | ±5.0 | ±100 | - | ±100 | µA |
| $I_{O(\text{pu/pd})}$ | power-up/power-down output current | $V_{CC} = 2.0 \text{ V}; V_O = 0.5 \text{ V}; V_I = \text{GND or } V_{CC}; \text{OEn HIGH}$ | [1] | - | ±5.0 | ±50 | - | ±50 µA |
| I_{OZ} | OFF-state output current | $V_{CC} = 5.5 \text{ V}; V_I = V_{IL} \text{ or } V_{IH}$ | | | | | | |
| | | $V_O = 2.7 \text{ V}$ | - | 5.0 | 50 | - | 50 | µA |
| | | $V_O = 0.5 \text{ V}$ | - | -5.0 | -50 | - | -50 | µA |
| I_{LO} | output leakage current | HIGH-state; $V_O = 5.5 \text{ V}; V_{CC} = 5.5 \text{ V}; V_I = \text{GND or } V_{CC}$ | - | 5.0 | 50 | - | 50 | µA |
| I_O | output current | $V_{CC} = 5.5 \text{ V}; V_O = 2.5 \text{ V}$ | [2] | -180 | -80 | -50 | -180 | -50 mA |
| I_{CC} | supply current | $V_{CC} = 5.5 \text{ V}; V_I = \text{GND or } V_{CC}$ | | | | | | |
| | | outputs HIGH-state | - | 0.5 | 250 | - | 250 | µA |
| | | outputs LOW-state | - | 25 | 38 | - | 38 | mA |
| ΔI_{CC} | additional supply current | outputs disabled | - | 0.5 | 250 | - | 250 | µA |
| | | per input pin; $V_{CC} = 5.5 \text{ V}$; one input at 3.4 V; other inputs at V_{CC} or GND | [3] | | | | | |
| | | outputs enabled | - | 0.5 | 1.5 | - | 1.5 | mA |
| | | outputs 3-state, one data input | - | 0.01 | 50 | - | 50 | mA |
| C_I | input capacitance | outputs 3-state; one enable input | - | 0.5 | 1.5 | - | 1.5 | mA |
| | | $V_I = 0 \text{ V or } V_{CC}$ | - | 4 | - | - | - | pF |
| C_O | output capacitance | outputs disabled; $V_O = 0 \text{ V or } V_{CC}$ | - | 7 | - | - | - | pF |

[1] This parameter is valid for any V_{CC} between 0 V and 2.1 V with a transition time of up to 10 ms. For $V_{CC} = 2.1 \text{ V}$ to $V_{CC} = 5 \text{ V} \pm 10 \%$, a transition time of up to 100 µs is permitted.

[2] Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

[3] This is the increase in supply current for each input at 3.4 V.

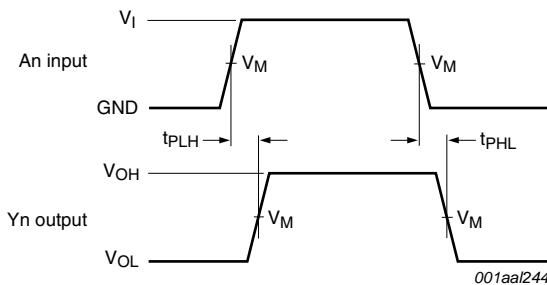
10. Dynamic characteristics

Table 7. Dynamic characteristics

GND = 0 V; for test circuit, see [Figure 7](#).

| Symbol | Parameter | Conditions | 25 °C; V _{CC} = 5.0 V | | | –40 °C to +85 °C; V _{CC} = 5.0 V ± 0.5 V | | Unit |
|------------------|-------------------------------------|---|-----------------------------------|-----|-----|--|-----|------|
| | | | Min | Typ | Max | Min | Max | |
| t _{PLH} | LOW to HIGH propagation delay | A _n to Y _n ; see Figure 5 | 1.1 | 3.0 | 4.4 | 1.1 | 4.8 | ns |
| t _{PHL} | HIGH to LOW propagation delay | A _n to Y _n ; see Figure 5 | 1.1 | 2.9 | 4.1 | 1.1 | 4.7 | ns |
| t _{PZH} | OFF-state to HIGH propagation delay | ̄ŌEn to Y _n ; see Figure 6 | 1.6 | 3.7 | 5.1 | 1.6 | 5.9 | ns |
| t _{PZL} | OFF-state to LOW propagation delay | ̄ŌEn to Y _n ; see Figure 6 | 2.6 | 4.6 | 5.9 | 2.6 | 6.9 | ns |
| t _{PHZ} | HIGH to OFF-state propagation delay | ̄ŌEn to Y _n ; see Figure 6 | 2.0 | 4.8 | 6.3 | 2.0 | 6.8 | ns |
| t _{PLZ} | LOW to OFF-state propagation delay | ̄ŌEn to Y _n ; see Figure 6 | 2.5 | 5.1 | 6.6 | 2.5 | 6.9 | ns |

11. Waveforms



V_M = 1.5 V

V_{OL} and V_{OH} are typical voltage output levels that occur with the output load.

Fig 5. Propagation delay input (A_n) to output (Y_n)

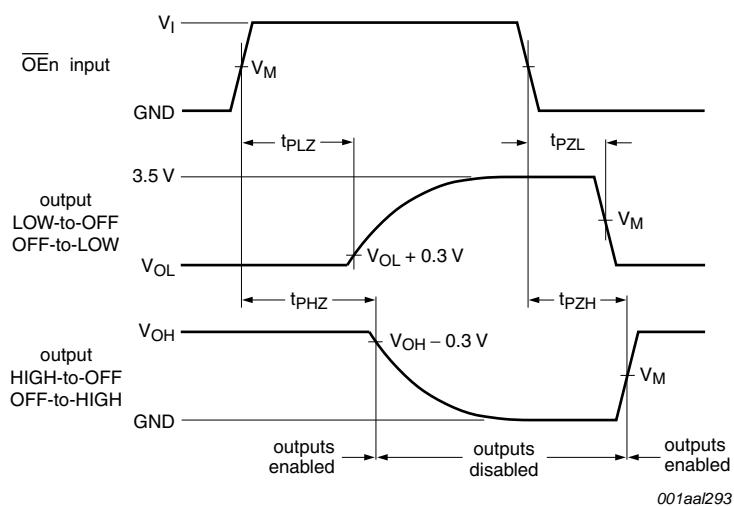
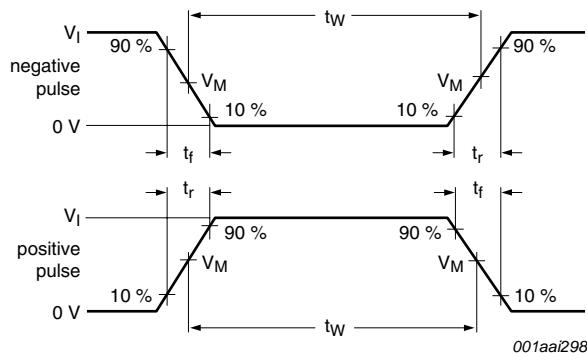
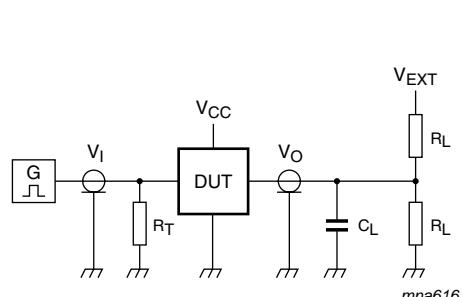


Fig 6. 3-state enable and disable times



a. Input pulse definition

Test data and V_{EXT} levels are given in [Table 8](#). R_L = Load resistance. C_L = Load capacitance including jig and probe capacitance. R_T = Termination resistance should be equal to output impedance Z_0 of the pulse generator. V_{EXT} = Test voltage for switching times.

b. Test circuit

Fig 7. Test circuit for measuring switching times

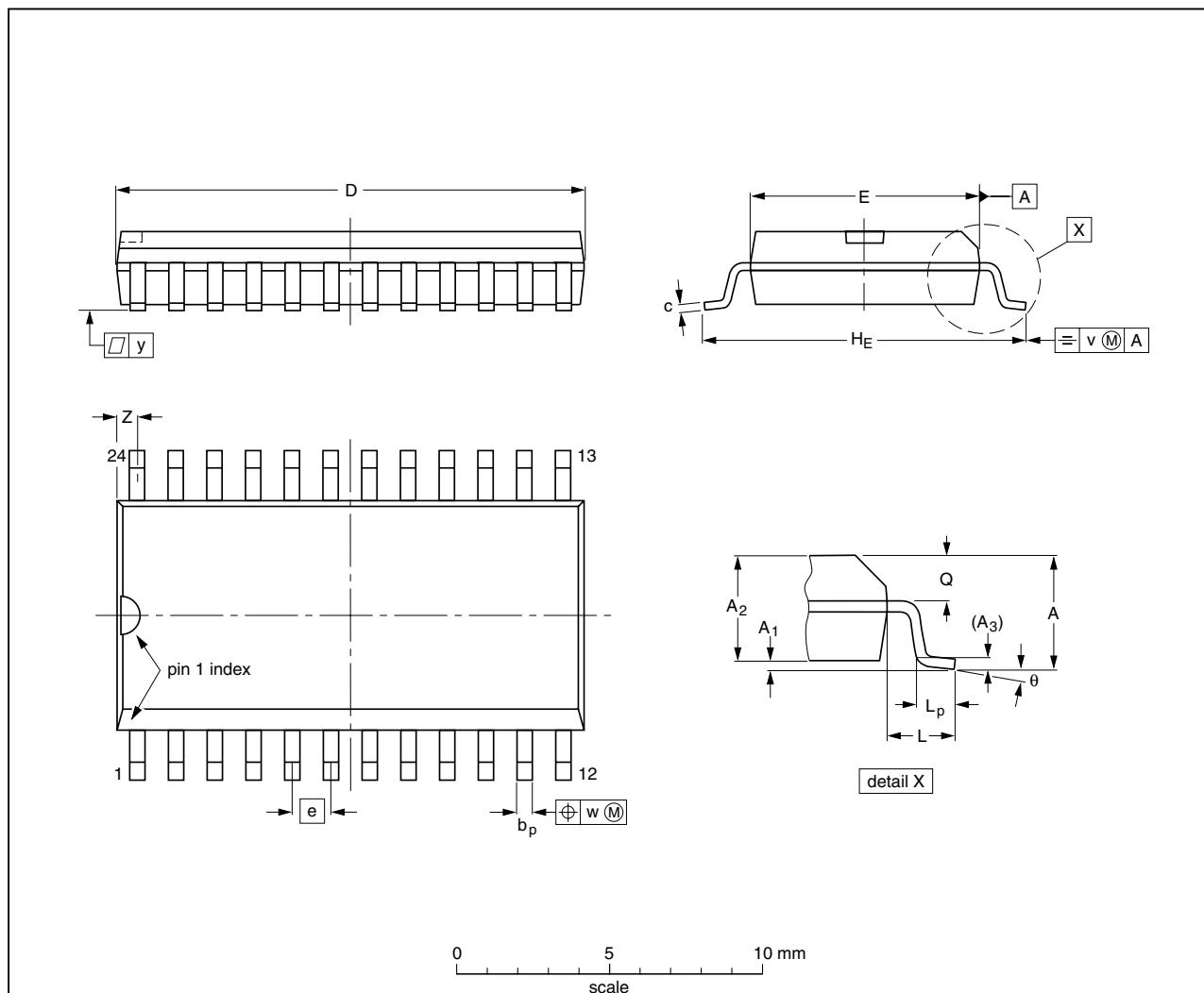
Table 8. Test data

| Input | | | | Load | | V_{EXT} | | |
|-------|-------|--------|-----------------------|-------|--------------|--------------------|--------------------|--------------------|
| V_I | f_I | t_W | t_r, t_f | C_L | R_L | t_{PHL}, t_{PLH} | t_{PZH}, t_{PHZ} | t_{PZL}, t_{PLZ} |
| 3.0 V | 1 MHz | 500 ns | $\leq 2.5 \text{ ns}$ | 50 pF | 500 Ω | open | open | 7.0 V |

12. Package outline

SO24: plastic small outline package; 24 leads; body width 7.5 mm

SOT137-1



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

| UNIT | A max. | A ₁ | A ₂ | A ₃ | b _p | c | D ⁽¹⁾ | E ⁽¹⁾ | e | H _E | L | L _p | Q | v | w | y | z ⁽¹⁾ | theta |
|--------|--------------|----------------|----------------|----------------|----------------|----------------|------------------|------------------|------|----------------|-------|----------------|----------------|------|------|-------|------------------|-------|
| mm | 2.65 0.1 | 0.3 2.25 | 2.45 | 0.25 | 0.49 0.36 | 0.32 0.23 | 15.6 15.2 | 7.6 7.4 | 1.27 | 10.65 10.00 | 1.4 | 1.1 0.4 | 1.1 1.0 | 0.25 | 0.25 | 0.1 | 0.9 0.4 | 8° |
| inches | 0.1 0.004 | 0.012 0.089 | 0.096 0.089 | 0.01 | 0.019 0.014 | 0.013 0.009 | 0.61 0.60 | 0.30 0.29 | 0.05 | 0.419 0.394 | 0.055 | 0.043 0.016 | 0.043 0.039 | 0.01 | 0.01 | 0.004 | 0.035 0.016 | 0° |

Note

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

| OUTLINE VERSION | REFERENCES | | | EUROPEAN PROJECTION | ISSUE DATE |
|--------------------|------------|--------|-------|------------------------|----------------------|
| | IEC | JEDEC | JEITA | | |
| SOT137-1 | 075E05 | MS-013 | | | 99-12-27 03-02-19 |

Fig 8. Package outline SOT137-1 (SO24)

SSOP24: plastic shrink small outline package; 24 leads; body width 5.3 mm

SOT340-1

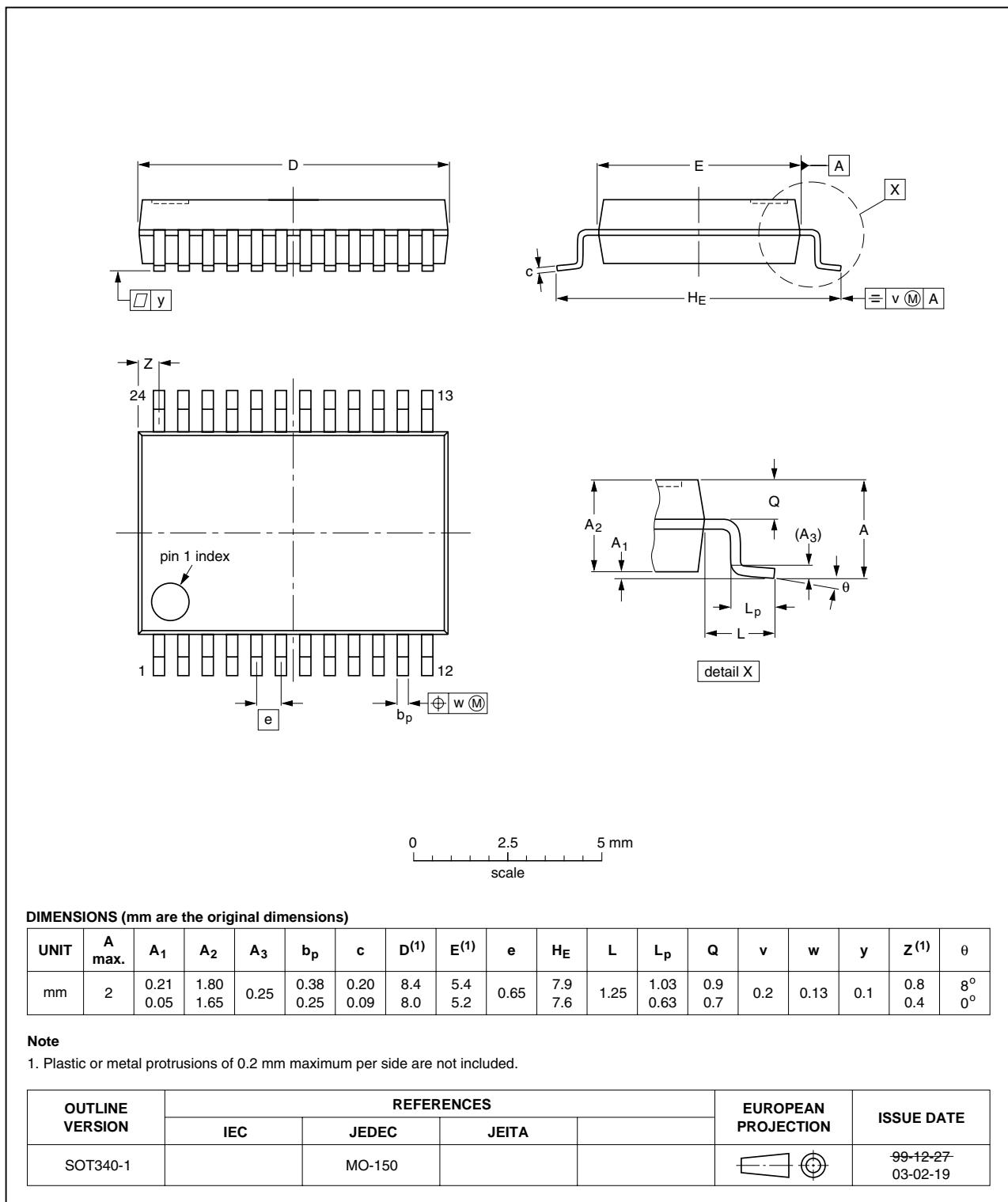


Fig 9. Package outline SOT340-1 (SSOP24)

TSSOP24: plastic thin shrink small outline package; 24 leads; body width 4.4 mm

SOT355-1

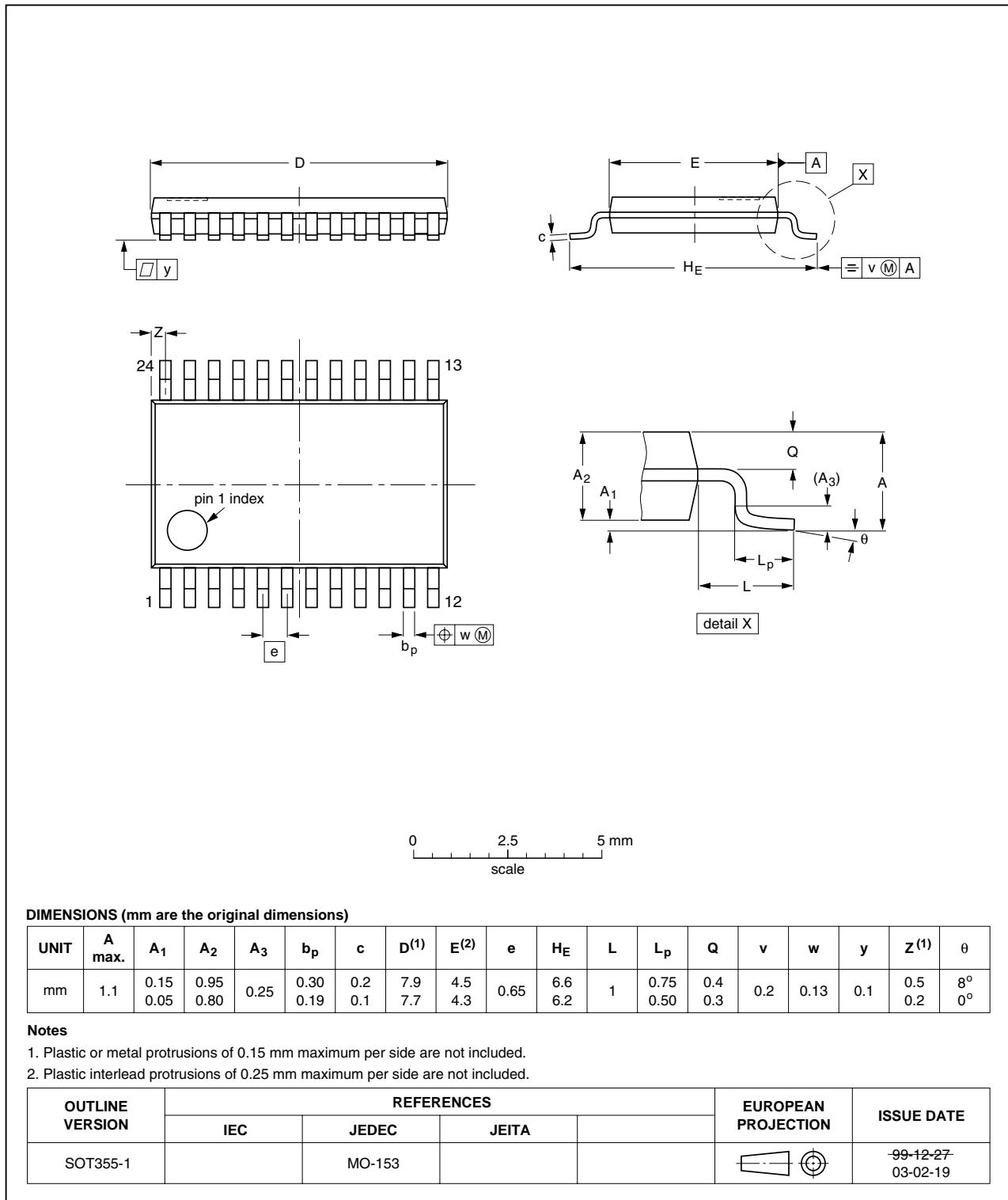


Fig 10. Package outline SOT355-1 (TSSOP24)

13. Abbreviations

Table 9. Abbreviations

| Acronym | Description |
|---------|---|
| BiCMOS | Bipolar Complementary Metal-Oxide Semiconductor |
| DUT | Device Under Test |
| ESD | ElectroStatic Discharge |
| HBM | Human Body Model |
| MM | Machine Model |

14. Revision history

Table 10. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes |
|----------------|---|-----------------------|---------------|------------|
| 74ABT827_4 | 20100401 | Product data sheet | - | 74ABT827_3 |
| Modifications: | <ul style="list-style-type: none"> The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. Legal texts have been adapted to the new company name where appropriate. DIP 24 (SOT222-1) package removed from Section 3 “Ordering information” and Section 12 “Package outline” | | | |
| 74ABT827_3 | 20100224 | Product data sheet | - | 74ABT827_2 |
| 74ABT827_2 | 19980116 | Product specification | - | 74ABT827_1 |
| 74ABT827_1 | 19950906 | Product specification | - | - |

15. Legal information

15.1 Data sheet status

| Document status ^{[1][2]} | Product status ^[3] | Definition |
|-----------------------------------|-------------------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.nxp.com>.

15.2 Definitions

Draft — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local NXP Semiconductors sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

Product specification — The information and data provided in a Product data sheet shall define the specification of the product as agreed between NXP Semiconductors and its customer, unless NXP Semiconductors and customer have explicitly agreed otherwise in writing. In no event however, shall an agreement be valid in which the NXP Semiconductors product is deemed to offer functions and qualities beyond those described in the Product data sheet.

15.3 Disclaimers

Limited warranty and liability — Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information.

In no event shall NXP Semiconductors be liable for any indirect, incidental, punitive, special or consequential damages (including - without limitation - lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort (including negligence), warranty, breach of contract or any other legal theory.

Notwithstanding any damages that customer might incur for any reason whatsoever, NXP Semiconductors' aggregate and cumulative liability towards customer for the products described herein shall be limited in accordance with the *Terms and conditions of commercial sale* of NXP Semiconductors.

Right to make changes — NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Applications — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

NXP Semiconductors does not accept any liability related to any default, damage, costs or problem which is based on a weakness or default in the customer application/use or the application/use of customer's third party customer(s) (hereinafter both referred to as "Application"). It is customer's sole responsibility to check whether the NXP Semiconductors product is suitable and fit for the Application planned. Customer has to do all necessary testing for the Application in order to avoid a default of the Application and the product. NXP Semiconductors does not accept any liability in this respect.

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) will cause permanent damage to the device. Limiting values are stress ratings only and (proper) operation of the device at these or any other conditions above those given in the Recommended operating conditions section (if present) or the Characteristics sections of this document is not warranted. Constant or repeated exposure to limiting values will permanently and irreversibly affect the quality and reliability of the device.

Terms and conditions of commercial sale — NXP Semiconductors products are sold subject to the general terms and conditions of commercial sale, as published at <http://www.nxp.com/profile/terms>, unless otherwise agreed in a valid written individual agreement. In case an individual agreement is concluded only the terms and conditions of the respective agreement shall apply. NXP Semiconductors hereby expressly objects to applying the customer's general terms and conditions with regard to the purchase of NXP Semiconductors products by customer.

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

Export control — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from national authorities.

Suitability for use in automotive applications — This NXP Semiconductors product has been qualified for use in automotive applications. The product is not designed, authorized or warranted to be suitable for use in medical, military, aircraft, space or life support equipment, nor in applications where failure or malfunction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors accepts no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

15.4 Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

16. Contact information

For more information, please visit: <http://www.nxp.com>

For sales office addresses, please send an email to: salesaddresses@nxp.com

17. Contents

| | | |
|-----------|---|-----------|
| 1 | General description | 1 |
| 2 | Features and benefits | 1 |
| 3 | Ordering information | 1 |
| 4 | Functional diagram | 2 |
| 5 | Pinning information | 3 |
| 5.1 | Pinning | 3 |
| 5.2 | Pin description | 3 |
| 6 | Functional description | 3 |
| 6.1 | Function table | 3 |
| 7 | Limiting values | 4 |
| 8 | Recommended operating conditions | 4 |
| 9 | Static characteristics | 5 |
| 10 | Dynamic characteristics | 6 |
| 11 | Waveforms | 6 |
| 12 | Package outline | 8 |
| 13 | Abbreviations | 11 |
| 14 | Revision history | 11 |
| 15 | Legal information | 12 |
| 15.1 | Data sheet status | 12 |
| 15.2 | Definitions..... | 12 |
| 15.3 | Disclaimers..... | 12 |
| 15.4 | Trademarks..... | 13 |
| 16 | Contact information | 13 |
| 17 | Contents | 14 |

Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.

© NXP B.V. 2010.

All rights reserved.

For more information, please visit: <http://www.nxp.com>

For sales office addresses, please send an email to: salesaddresses@nxp.com

Date of release: 1 April 2010

Document identifier: 74ABT827_4